

<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10555664	ASSAF ET AL.
	Examiner	Art Unit
	Loewe, Sun Jae Y	1626

### SEARCHED

Class	Subclass	Date	Examiner

### SEARCH NOTES

Search Notes	Date	Examiner
restriction requirement	10/1/2007	sl
stn structure: registry & caplus	12-28-2007	sl
palm all inventors	12-28-2007	sl
STN: registry & caplus updated	9-29-2008	sl
PALM all inventor updated	9-29-08	sl
STN registry & caplus updated	5-5-2009	sl
PALM all inventors updated	5-5-2009	sl
STN registry & caplus updated	12-4-2009	sl
PALM all inventors updated	12-4-2009	sl

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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